

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/608,054	CHAN, MICHAEL L.F.	
		Examiner	Art Unit	Page 1 of 1
		Bena Miller	3725	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-610,337	09-1898	Ames	229/120.1
*	B	US-5,232,087	08-1993	Schluger, Allen	206/45.29
*	C	US-5,038,930	08-1991	Holtkamp, Jr., Reinhold	206/232
*	D	US-2,636,597	04-1953	HINZ LESTER F	206/776
*	E	US-6,398,026	06-2002	Parsons, Kevin L.	206/349
*	F	US-6,409,568	06-2002	S.o slashed.gaard et al.	446/73
*	G	US-3,415,407	12-1968	ALDEN CHARLES L; et. al.	220/4.23
*	H	US-4,330,060	05-1982	Thornton, Craig E.	206/459.5
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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